

Notice of References Cited	Application/Control No. 10/609,503	Applicant(s)/Patent Under Reexamination SHIMIZU ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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	N	JP 2002270020 A	09-2002	Japan	TAKEDA et al.	F21V 08/00
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